FORM PTO 1449 (modified)			ATTY DOCKET NO. 03500.015865.	015865. APPLICATION NO. 09/973,054			
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ER INITIAL	NUMBER	DATE	NAME	CLASS	SUBCLASS	JF APPROPRIATE	
RnI	5,742,659	04/21/98	Atac et al.	378	98,8		
Rns	5,896,172	04/20/99	Korthout et al.	348	248		
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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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fut	CN 1213249A	04/04/99	China			Abstract		
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ln2	OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)  Office Action (in English) from counterpart application 01130198.8 from Patent Office in China, dated March 26, 2004.							
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Sheet 1 of 1

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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